

Endcap Hadronic Testbeam Data Analysis

Electron and Pion Results from April 1998

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July 9, 1998

Outline

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Electron Analysis

The Data

- Electron data were analysed at 4 different impact points:
 - Point D, Cell 5: $x = -100$ mm $y = +83$ mm
 - Point E, Cell 78: $x = +100$ mm $y = +83$ mm
 - Point H, Cell 3: $x = -100$ mm $y = -67$ mm
 - Point I, Cell 76: $x = +100$ mm $y = -67$ mm

Energy (GeV)	point D Run #	point E Run #	point H Run #	point I Run #
20	7353	7350	7352	7351
40	7298	7291	7295	7294
60	7255	7259	7253	7260
80	7299	7311	7303	
100	7334	7341	7330	7342
119.1	7065	7088	7071	7079

Electron Analysis

Clustering, Energy Reconstruction

- A three cell cluster was chosen to reconstruct the energy of the electrons. A map of the chosen cells is presented in [Figure 1](#) for each impact point.
- Trigger cuts: physics, not muon, not random, three cell “subcluster signal shape” requirement (described later).
- Using the 3 cell cluster, the energy was reconstructed and fit in a $\pm 3\sigma$ range for each run, as shown in [Figure 2](#). Signal peaks were reconstructed using the `hec_adc` digital filtering peak finding package.

Electron Analysis

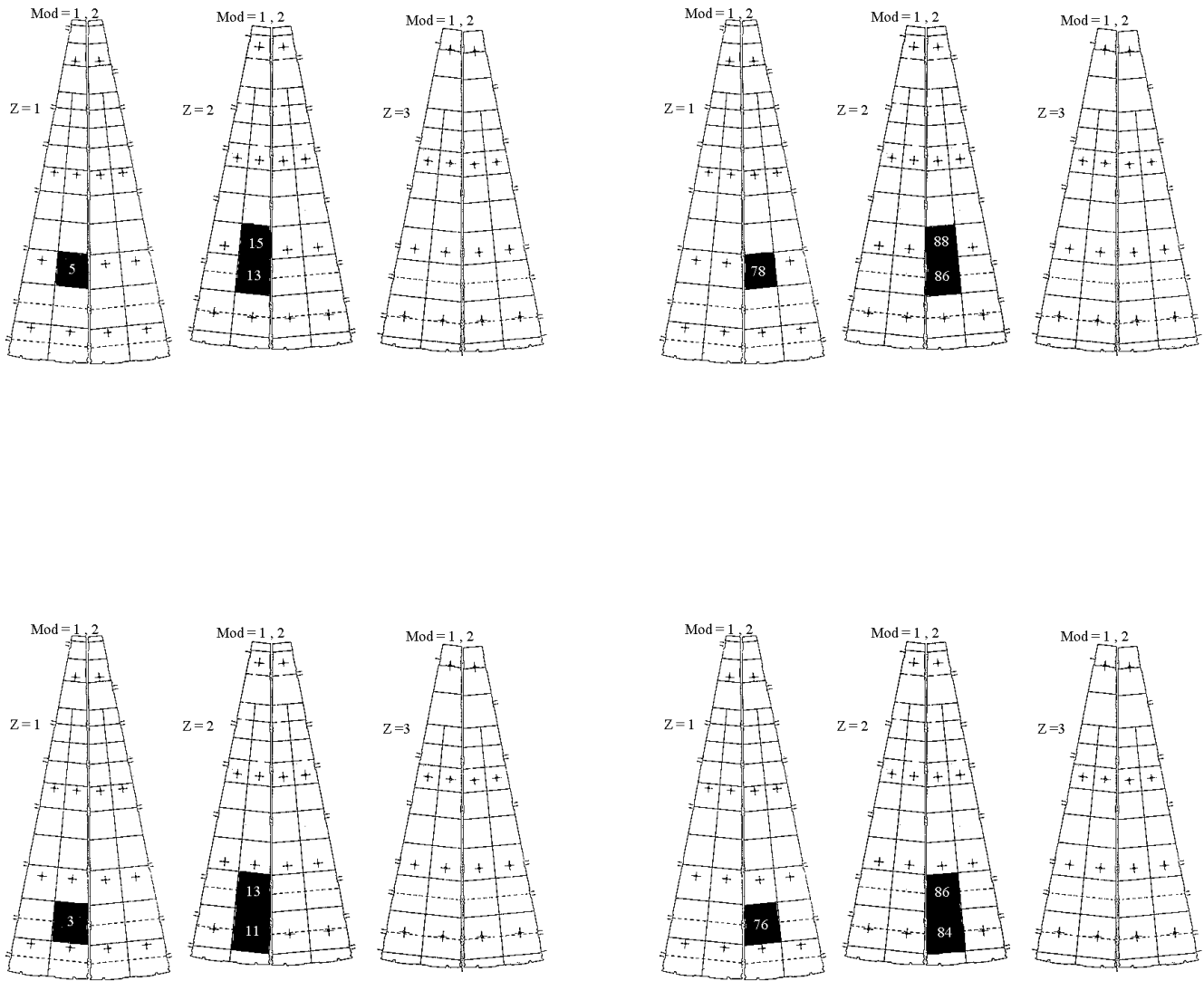


Figure 1: Map of cells used in electron clusters: points D, E, I, H (clockwise).

Electron Analysis

HEC Testbeam, April 1998

ELECTRONS Impact Cell 5

Cluster Cells (5, 13, 15)

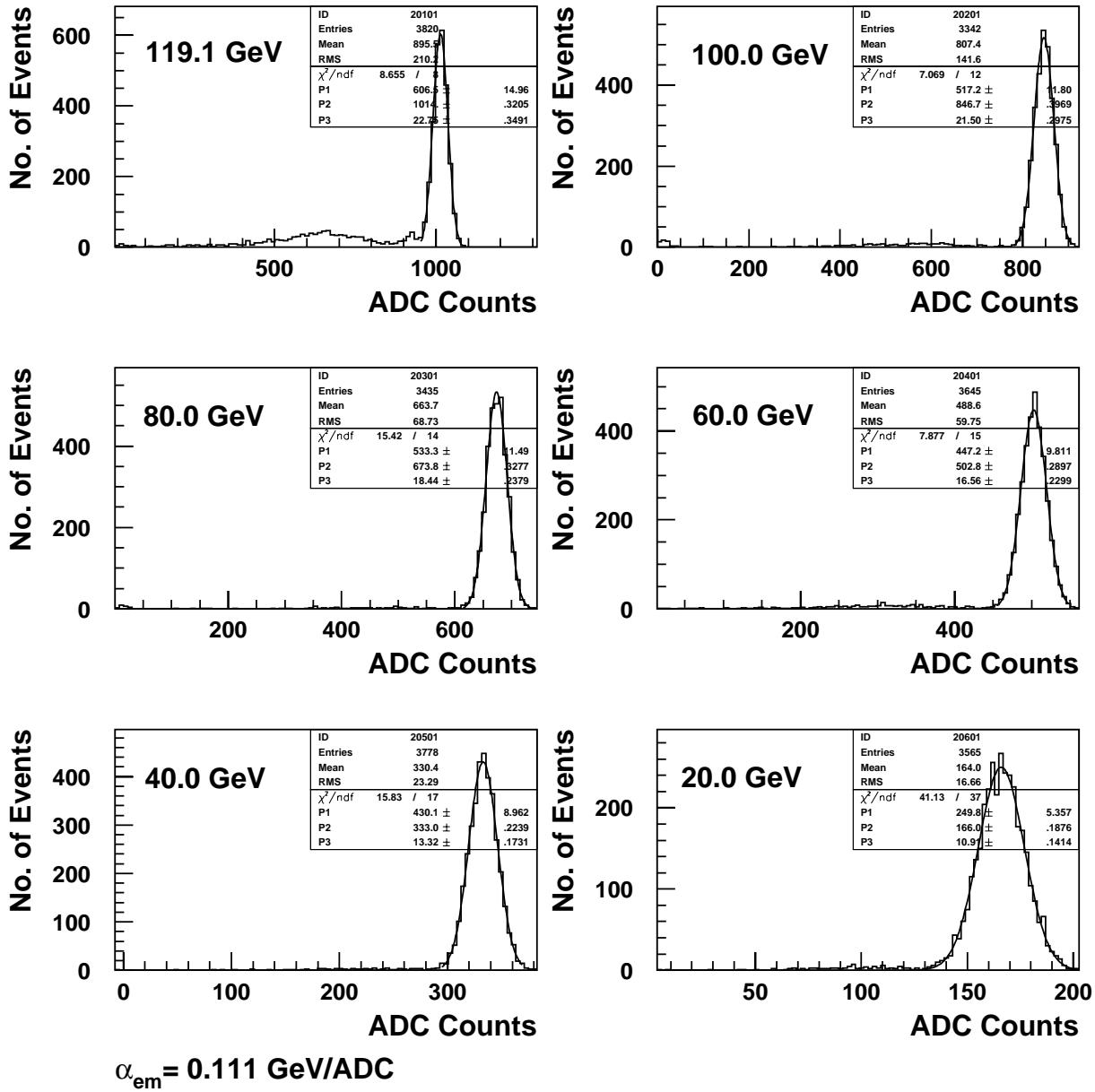


Figure 2: Electron cluster energy (uncalibrated data) for a typical impact point.

Electron Analysis

- The global electromagnetic scale (α_{em}) was determined by minimizing the following χ^2 :

$$\chi^2 = \sum_{\text{runs}} \frac{(\alpha_{em} \langle E_{cl}(\text{adc}) \rangle - E_o)^2}{\sigma^2}$$

where $\langle E_{cl}(\text{adc}) \rangle$ is the average from the fits shown in Figure 2.

We conclude:

$$\alpha_{em} = 0.11 \text{ GeV/adc} = 3.4 \text{ GeV}/\mu\text{A}$$

averaged over impact points D, E, H, & I.

Response

- Using α_{em} , we obtain the response plot shown in [Figure 3](#), wherein data from all four impact points is superimposed.
- The response uniformity is improved by the calibration.
- Response linearity within 1%.

Electron Analysis

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Electrons, Impact Points H,D,E,I

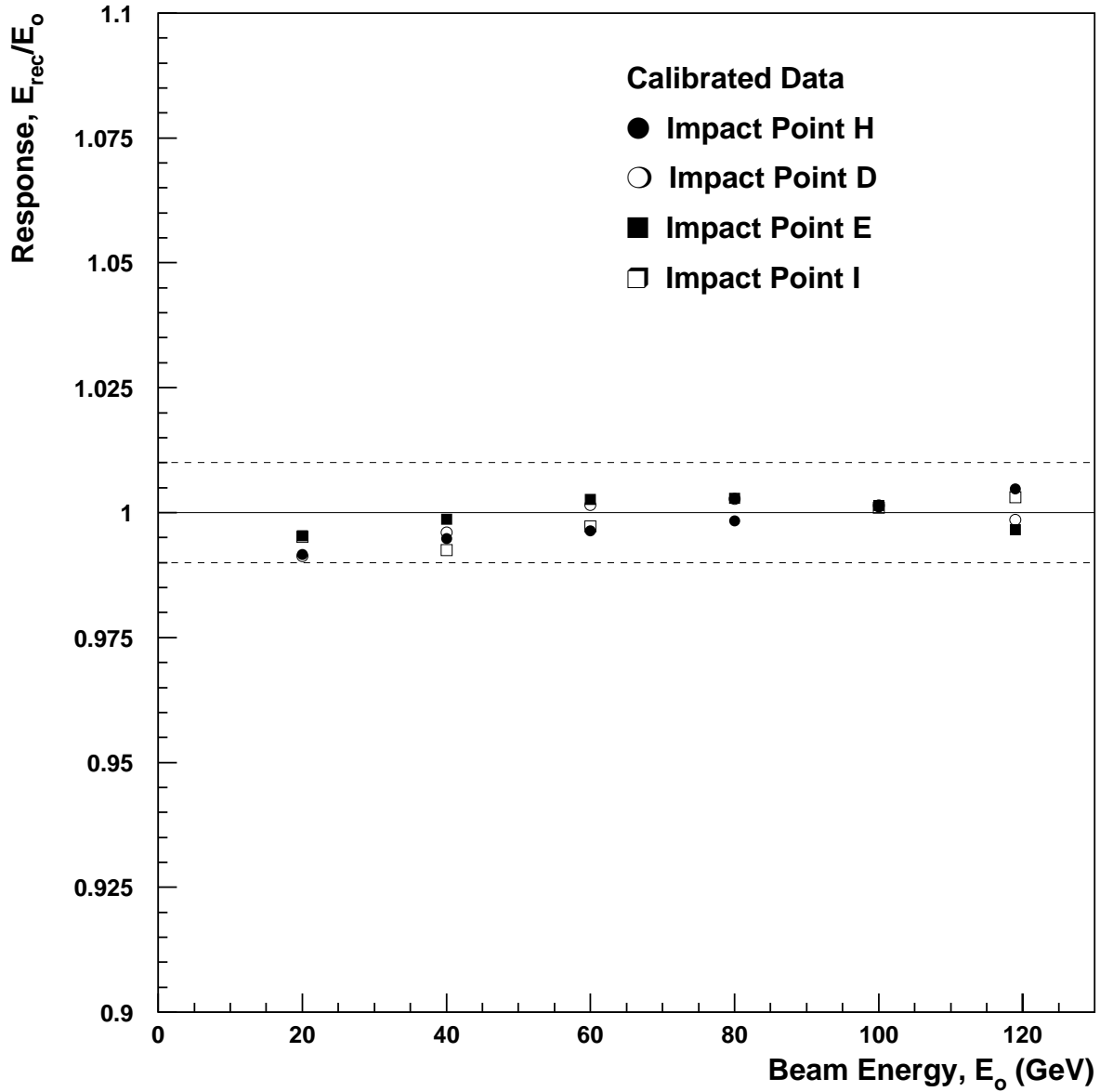


Figure 3: Electron response of calorimeter vs. energy.

Electron Analysis

Energy Resolution

- The energy resolution curve was fit to the usual parametrization:

$$\frac{\sigma}{E} = \frac{\alpha}{\sqrt{E_0}} \oplus \beta \oplus \frac{\gamma}{E_0}$$

- This function was fit with three parameters free.
- Results of these fits are shown in [Figure 4](#).

We obtain a resolution of (for the 4 impact points combined, calibrated case):

$$\frac{21.5\%}{\sqrt{E_0}} \oplus 0.05\% \oplus \frac{0.8 \text{ GeV}}{E_0}$$

- Within errors, the energy resolution obtained is the same for calibrated and uncalibrated data.
- A 3% improvement in the sampling term is realized over our results presented May 1998. This is the result of the use of digital filtering and better electron isolation cuts.

Electron Analysis

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Electrons, Impact Points H,D,E,I

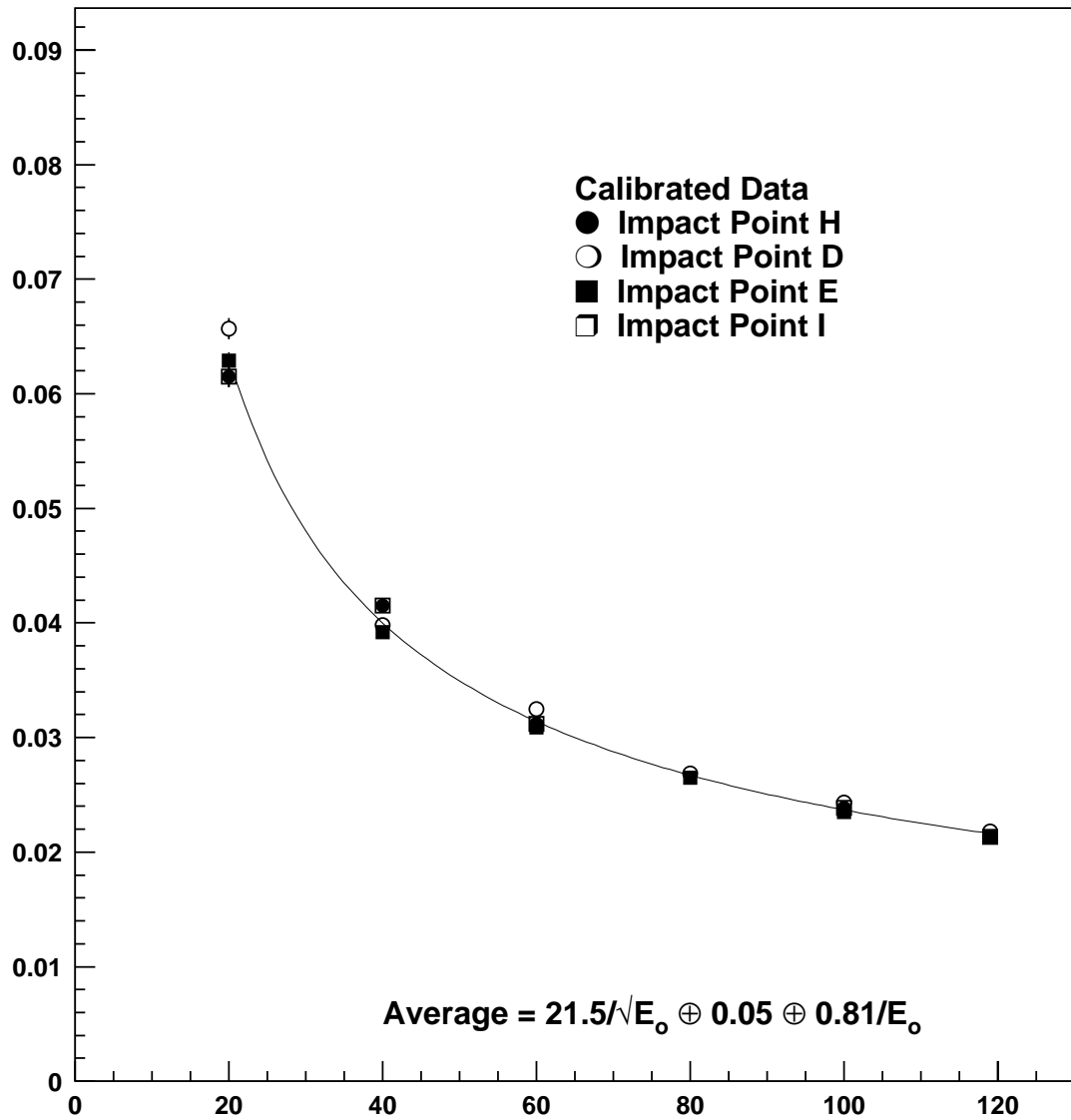


Figure 4: Electron energy resolution with 3 free parameters.

Pion Analysis

The Data

- Pion data at 4 impact points were analysed:

→ Module 1

* Point D, Cell 5: $x = -100$ mm $y = +83$ mm

* Point H, Cell 3: $x = -100$ mm $y = -67$ mm

→ Module 2 - HV problem

* Point E, Cell 78: $x = +100$ mm $y = +83$ mm

* Point I, Cell 76: $x = +100$ mm $y = -67$ mm

Energy (GeV)	point H Run #	point d Run #	point e Run #	point i Run #
20	7369	7354	7371	
40	7296	7297	7292	7293
60	7280	7281	7287	7285
80	7304	7300	7312	7310
100	7331	7335	7340	7343
120	7182	7196	7154	7146
180	7356	7355	7359	7360

Pion Analysis

Clustering and Energy Reconstruction Methods

- A cluster was defined for each impact point. Several cluster sizes were evaluated. Results are presented for 19 cell clusters. $\geq 97\%$ of the total energy deposited in the calorimeter is contained.
- A map of the chosen cells is presented in Figure 5 for each impact point.
- The clusters are approximately symmetric with respect to one another.

Pion Analysis

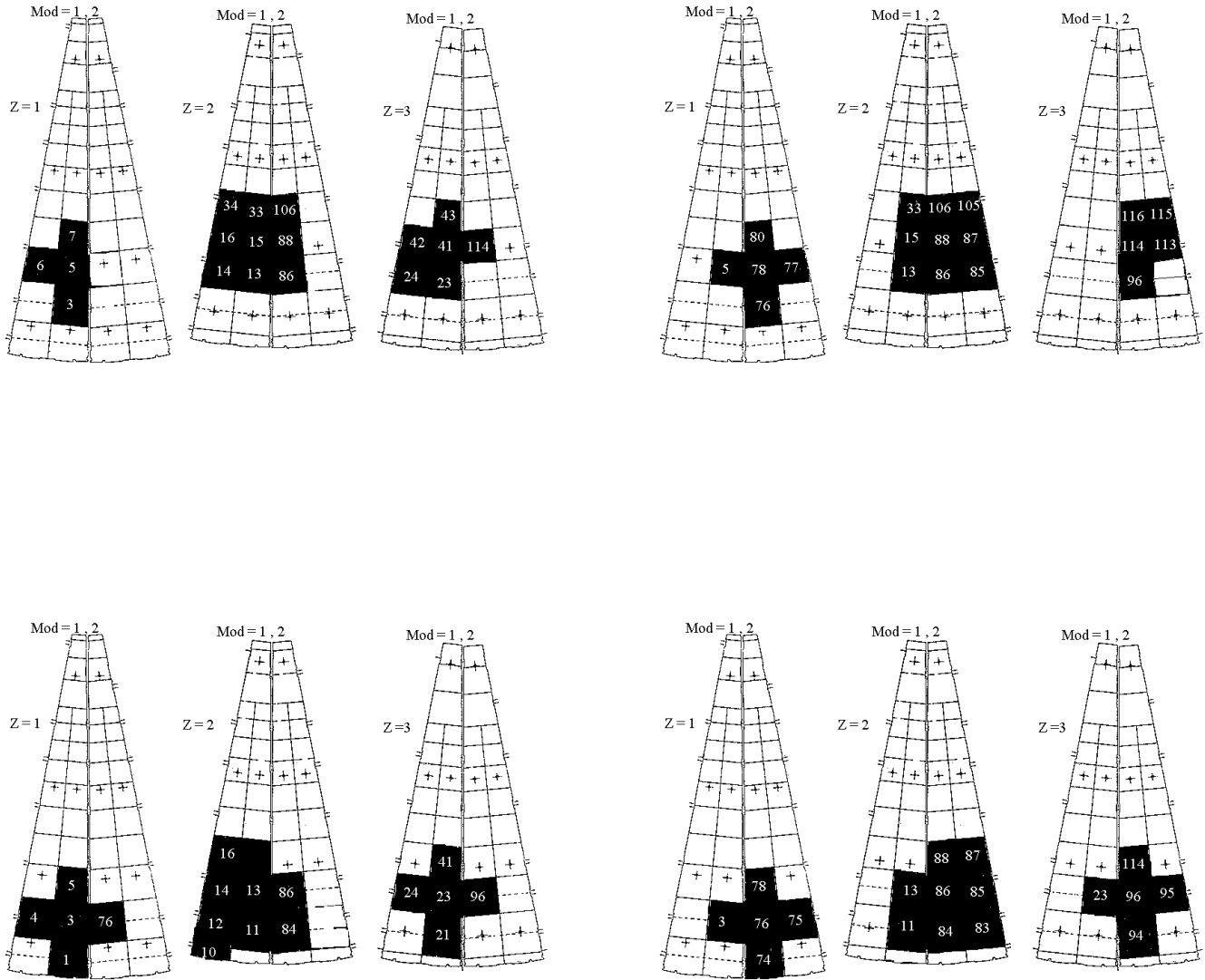


Figure 5: Map of cells used in pion clusters: points D, E, I, H (clockwise).

Pion Analysis

Three different methods were employed to reconstruct the pion energy:

- Simple Cubic Fit

The signal peak *for each cell* in the cluster was determined using the `hec_adc` cubic fit package. In order to properly treat low energy cells:

- The signal maximum is constrained to be between the 7th and 9th time slice inclusively.
- The maximum of signals with low energy (defined as $E \leq 10\sigma_{ped}$) is taken to be the height of the 8th time slice (i.e. cubic fit is not employed).

- Cubic Fit Over Entire Cluster

The raw signal for each cell is summed over the entire cluster time slice by time slice:

$$E_{cluster}(i) = \sum_{j=1}^{cells} E_j(i),$$

where $i=1,\dots,16$ time slices.

A cubic fit is then performed on this summed signal, $E_{cluster}(i)$.

Pion Analysis

- Digital Filtering

The signal peak *for each cell* was determined using the `hec_adc` digital filtering package. Digital filtering weights were unavailable for several cells (due to a lack of calibration data). In these cases the signal peak was determined using simple cubic fit, as described above.

In all three cases energy dependent depth weights were employed.

Pion Analysis

Pion Sample (the Cuts)

- Trigger cuts: physics, not random, not muon
- Subcluster signal shape cut:
 - Trigger cuts did not properly veto “zero energy” events
 - Use 3 cell sub-cluster of cells within 19 cell pion cluster, at least one of these cells must contain signal (as defined by “Striegel signal search”). See [Figure 6](#)
- final data sample (after all cuts), point H shown in [Figure 7](#)

Calculation of the Hadronic Scale (α_{had})

- First obtain α_{had} (as for electrons). $\alpha_{\text{had}} = .141 \text{ GeV}/\text{adc} = 4.3 \text{ GeV}/\mu\text{A}$ (ave. over 4 impact points).
- To optimize the resolution, one weight for each depth (c_z) was calculated by minimizing the following equation for each energy:

$$\sum_{\text{events}} \frac{(\alpha_{\text{had}} \Sigma_z c_z E_{\text{cl}}^z(\text{adc}) - E_o)^2}{\sigma^2}$$

[Figure 8](#) shows the depth weights obtained for impact point H using this method.

Pion Analysis

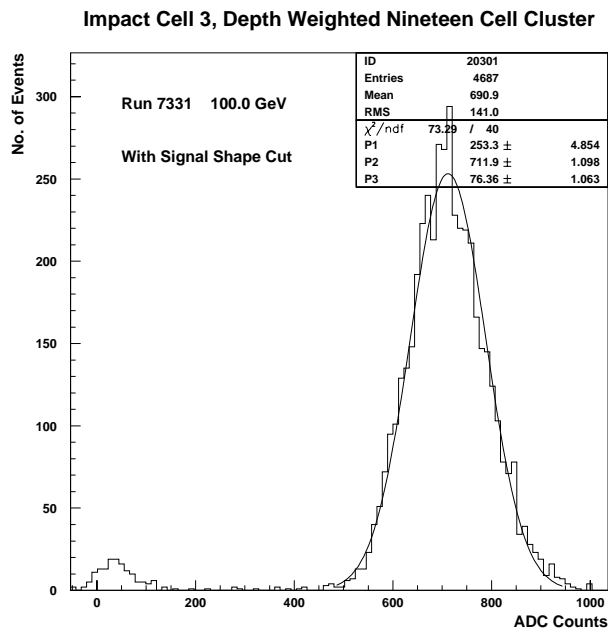
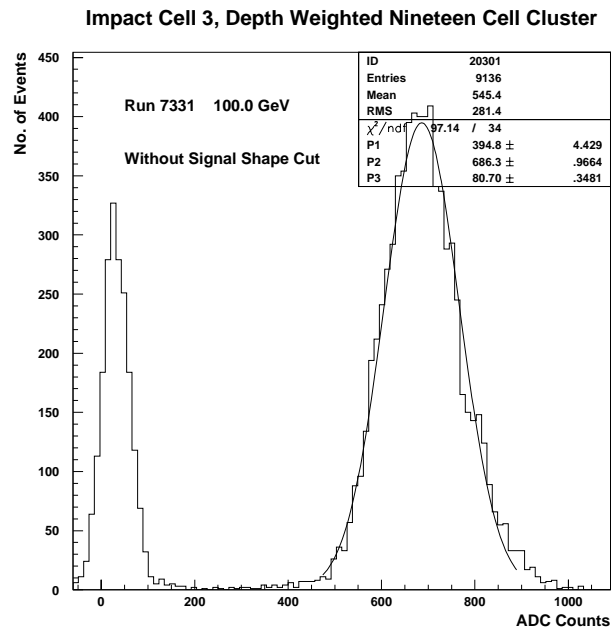


Figure 6: Data sample for point H before and after subcluster cut .

Pion Analysis

HEC Testbeam, April 1998

Impact Cell 3, Depth Weighted Nineteen Cell Cluster

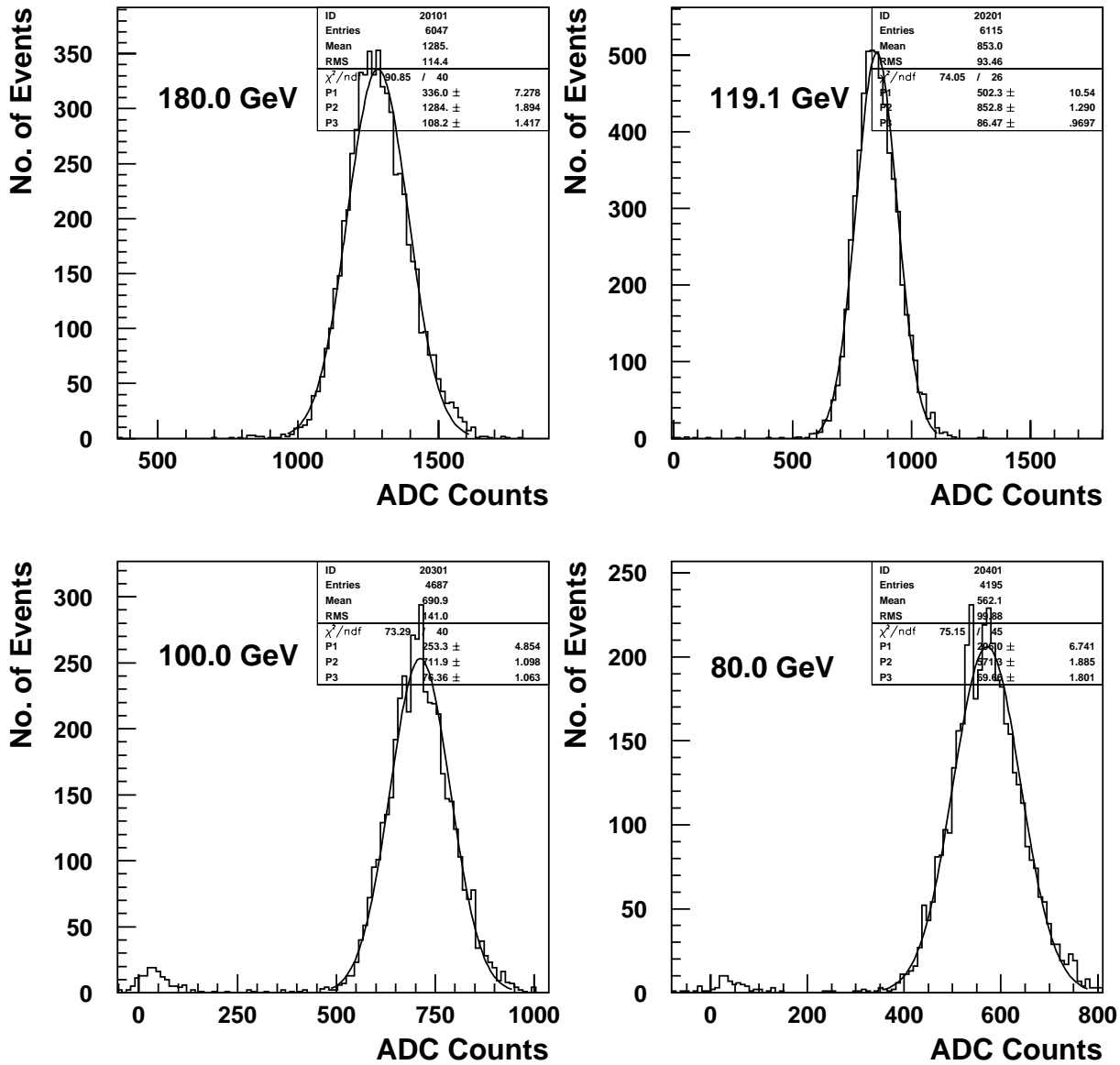
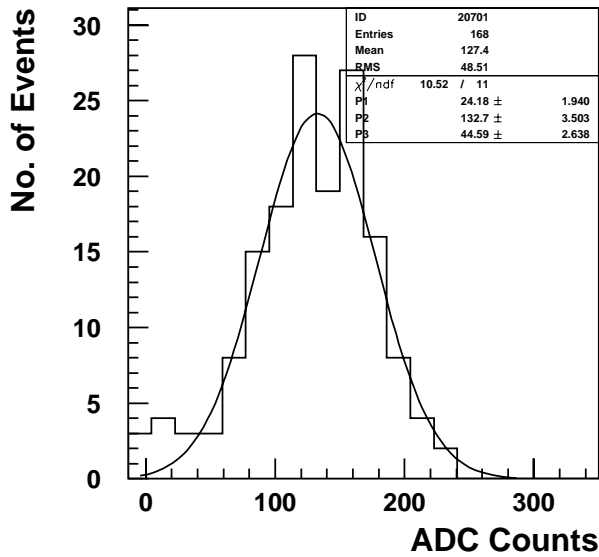
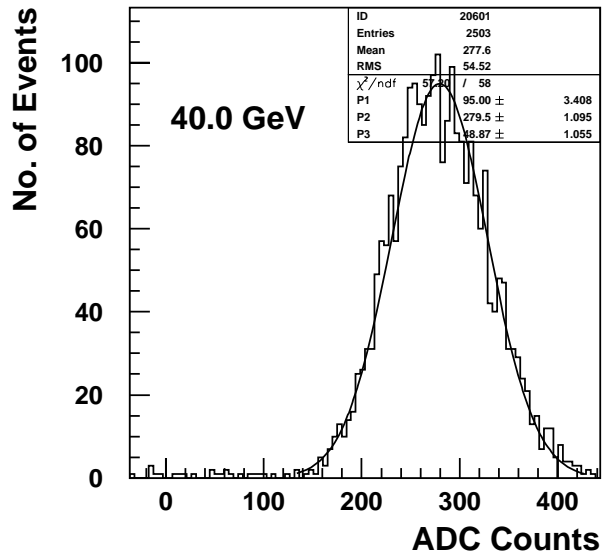
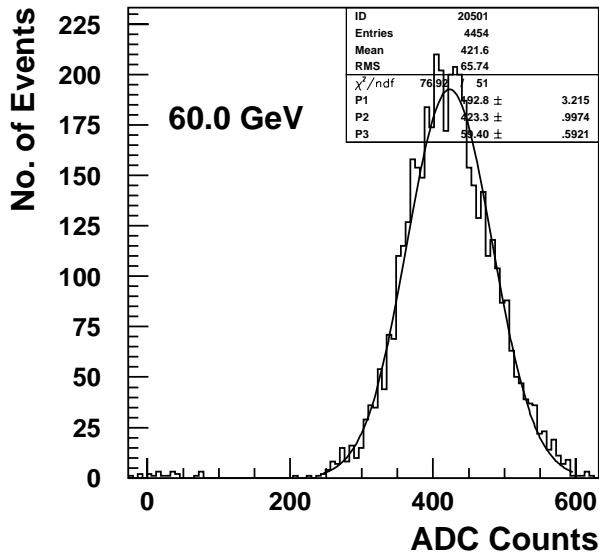


Figure 7: Data sample for point H after cuts .

Pion Analysis

HEC Testbeam, April 1998

Impact Cell 3, Depth Weighted Nineteen Cell Cluster



Pion Analysis

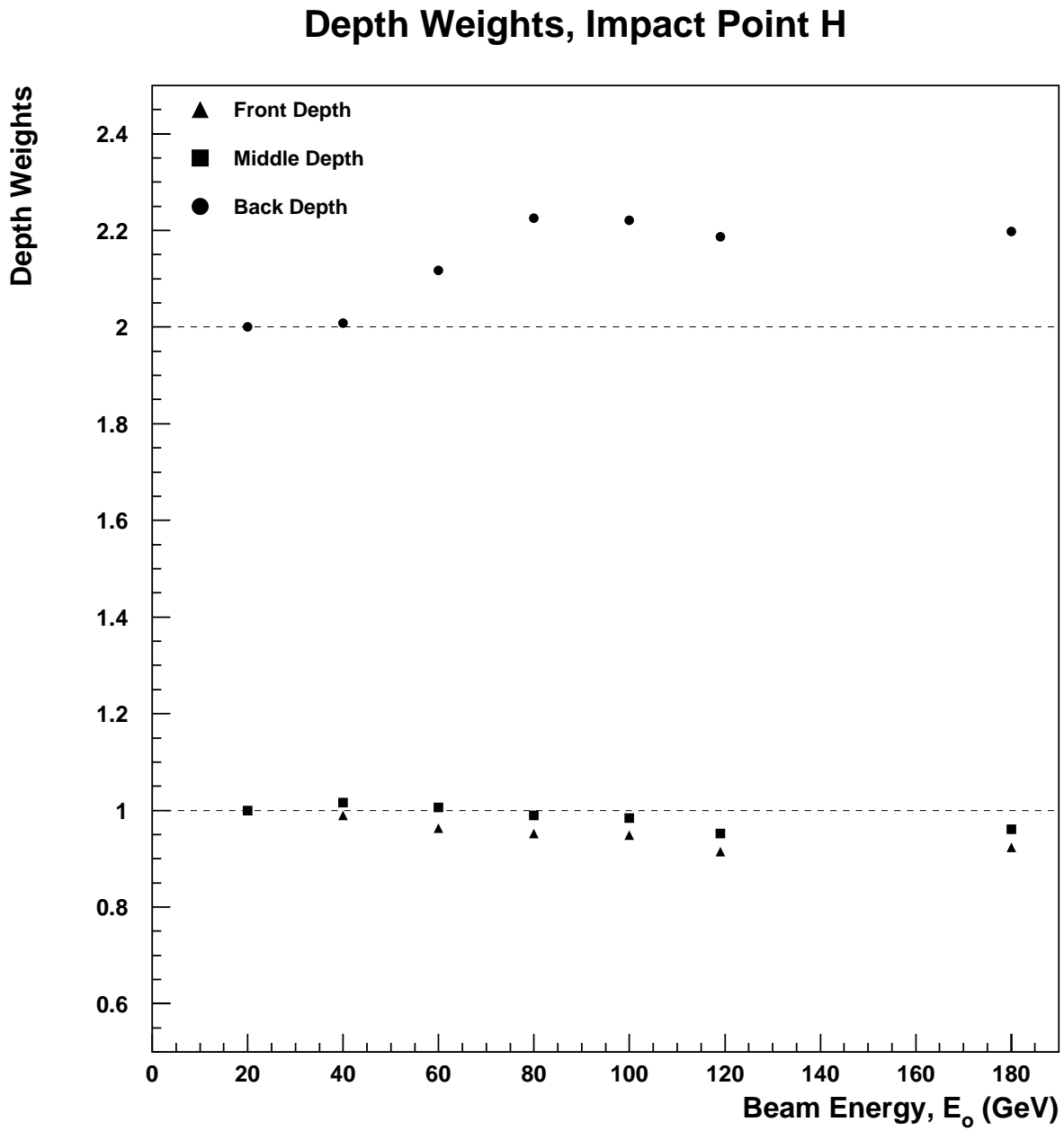


Figure 8: Depth weights obtained for pions, impact point H .

Pion Analysis

Resolution and Response, Point H

- Results of the resolution fits on a 19 cell cluster with 3 free parameters are shown in [Figure 9](#). For this impact point, using digital filtering, we obtain a resolution of:

$$\frac{71\%}{\sqrt{E_o}} \oplus 5.8\% \oplus \frac{5.4 \text{ GeV}}{E_o} \quad 19 \text{ Cells, Uncalibrated Data}$$

$$\frac{88\%}{\sqrt{E_o}} \oplus 4.6\% \oplus \frac{3.9 \text{ GeV}}{E_o} \quad 19 \text{ Cells, Calibrated Data}$$

- The results for different cluster sizes are presented in [Figure 10](#) and are summarized below

$$\frac{89\%}{\sqrt{E_o}} \oplus 5.8\% \oplus \frac{3.6 \text{ GeV}}{E_o} \quad 10 \text{ Cells, Calibrated Data}$$

$$\frac{75\%}{\sqrt{E_o}} \oplus 5.2\% \oplus \frac{6.3 \text{ GeV}}{E_o} \quad 30 \text{ Cells, Calibrated Data}$$

- [Figure 11](#) shows that the response for pions at this impact point varies by about 7% from 20-180 GeV. Calibration does not seem to effect these results

Pion Analysis

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Pions, Impact Point H

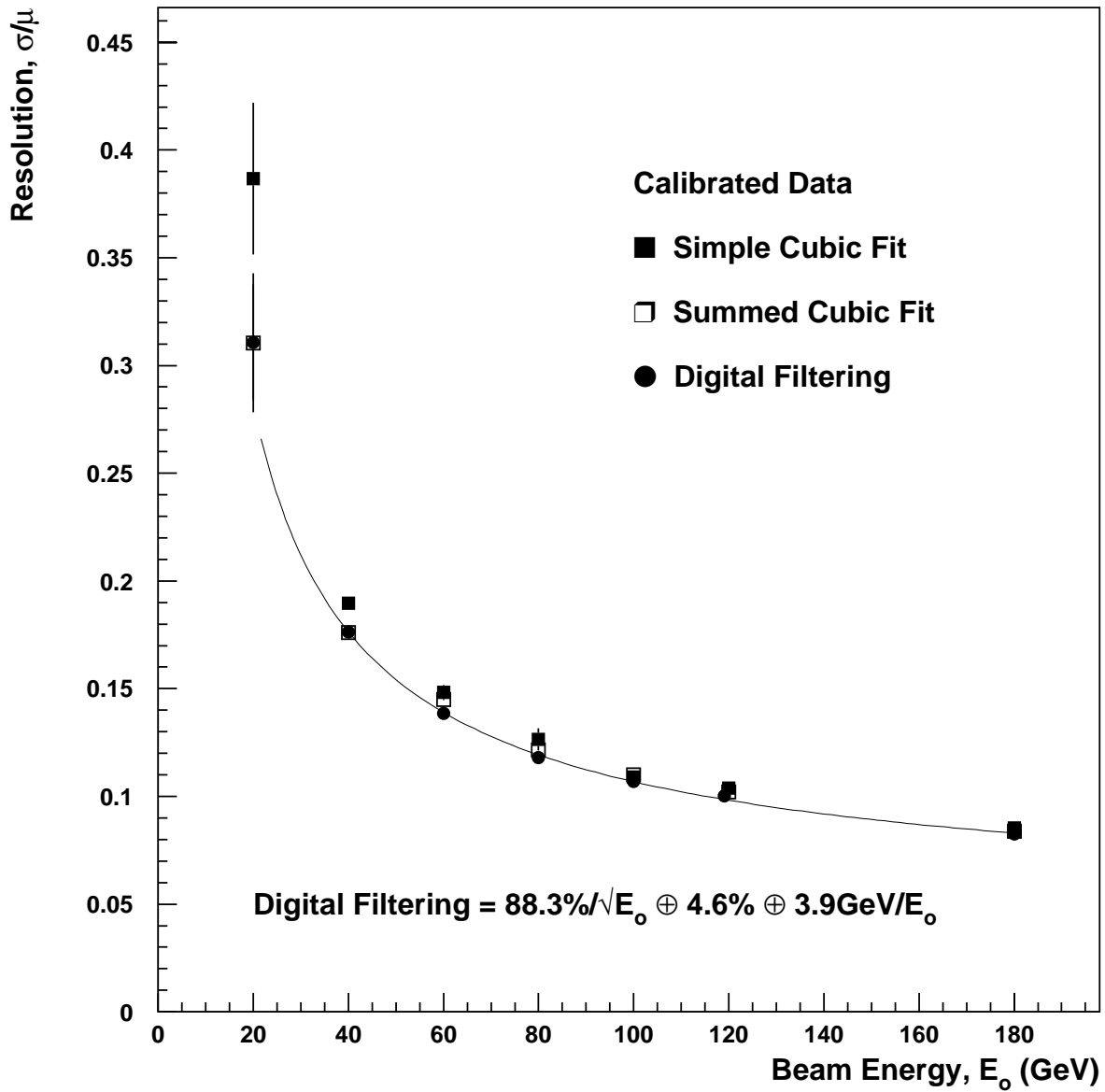


Figure 9: Resolution results obtained for three different fitting methods

Pion Analysis

HEC Testbeam, April 1998

Pions, Impact Point H

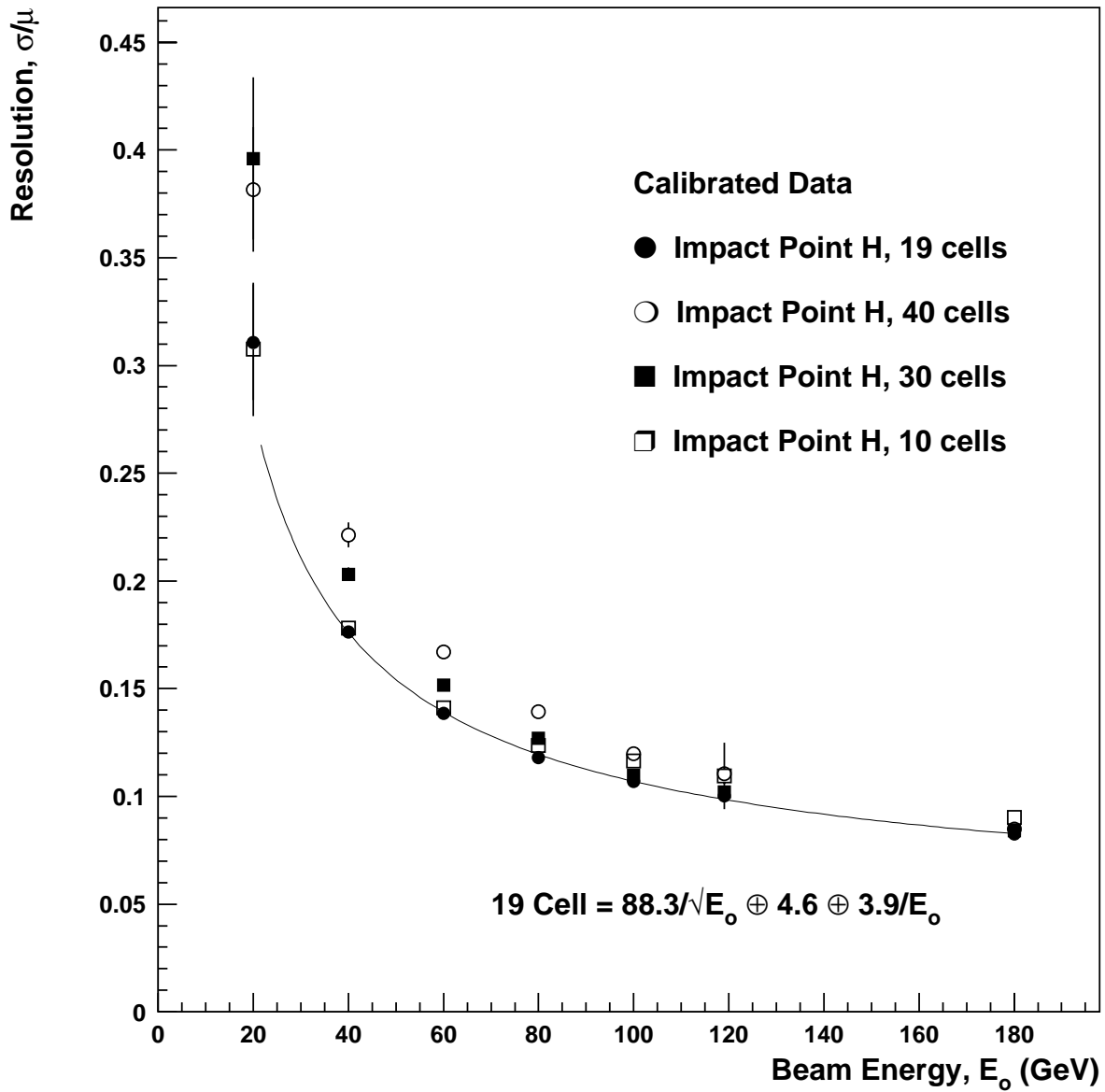


Figure 10: Resolution results obtained for four different cluster sizes

Pion Analysis

HEC Testbeam, April 1998

Pions, Impact Point H

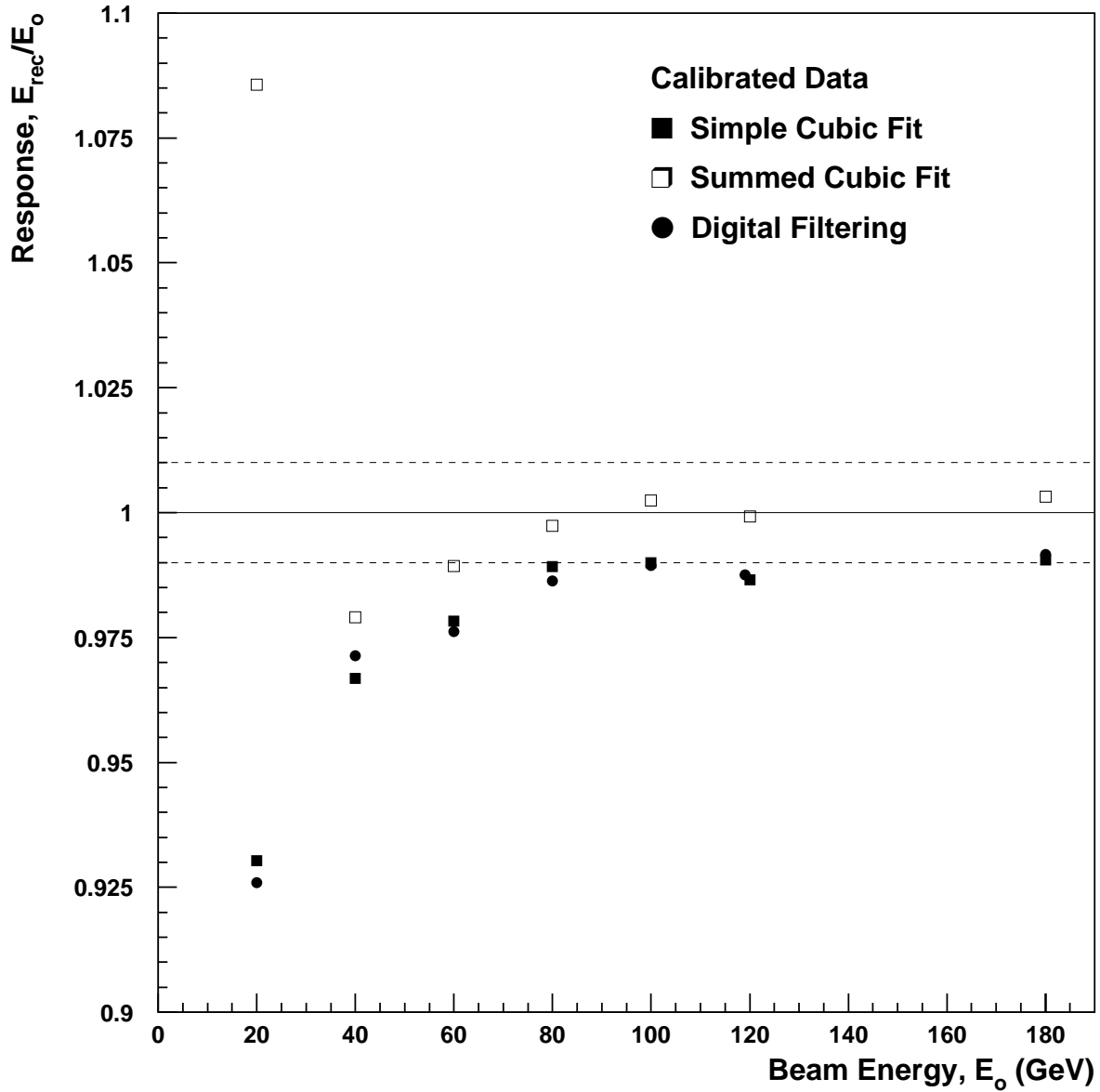


Figure 11: Pion response at impact point H .

Pion Analysis

Comparison, 4 Impact Points

- The pion energy resolution was obtained (using digital filtering) at 4 different impact points (H,D,E,I). The results were consistent at all 4 points. This is shown in [Figure 12](#).
- The response for pions was also obtained for each of these impact positions. The results are overlaid in [Figure 13](#).
- Results are reasonably consistent in different impact points, despite HV problems in module 2.

Pion Analysis

HEC Testbeam, April 1998

Pions, Impact Points H,D,E,I

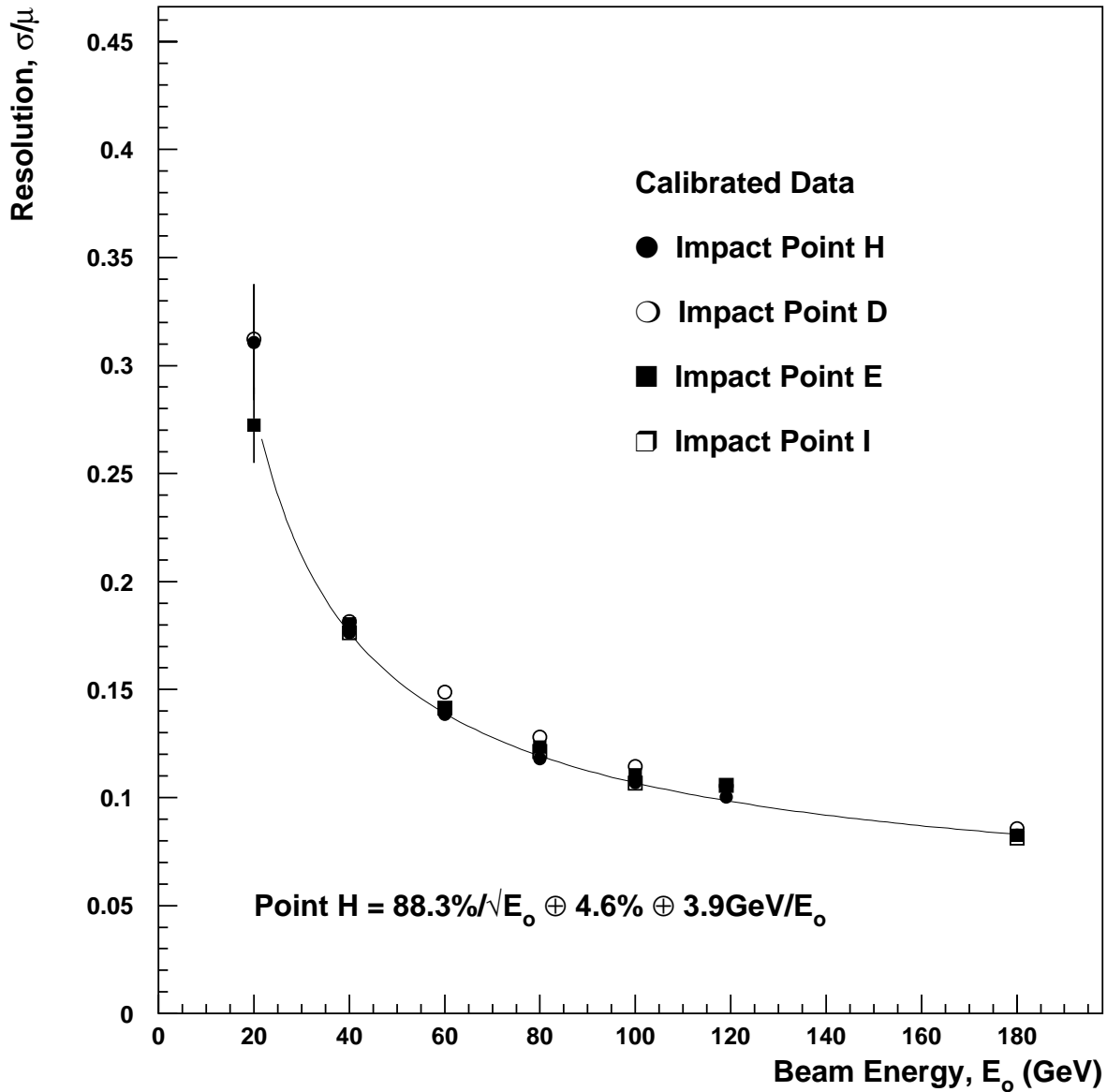


Figure 12: Energy resolution for pions at 4 different impact points (digital filtering)

Pion Analysis

HEC Testbeam, April 1998

Pions, Impact Points H,D,E,I

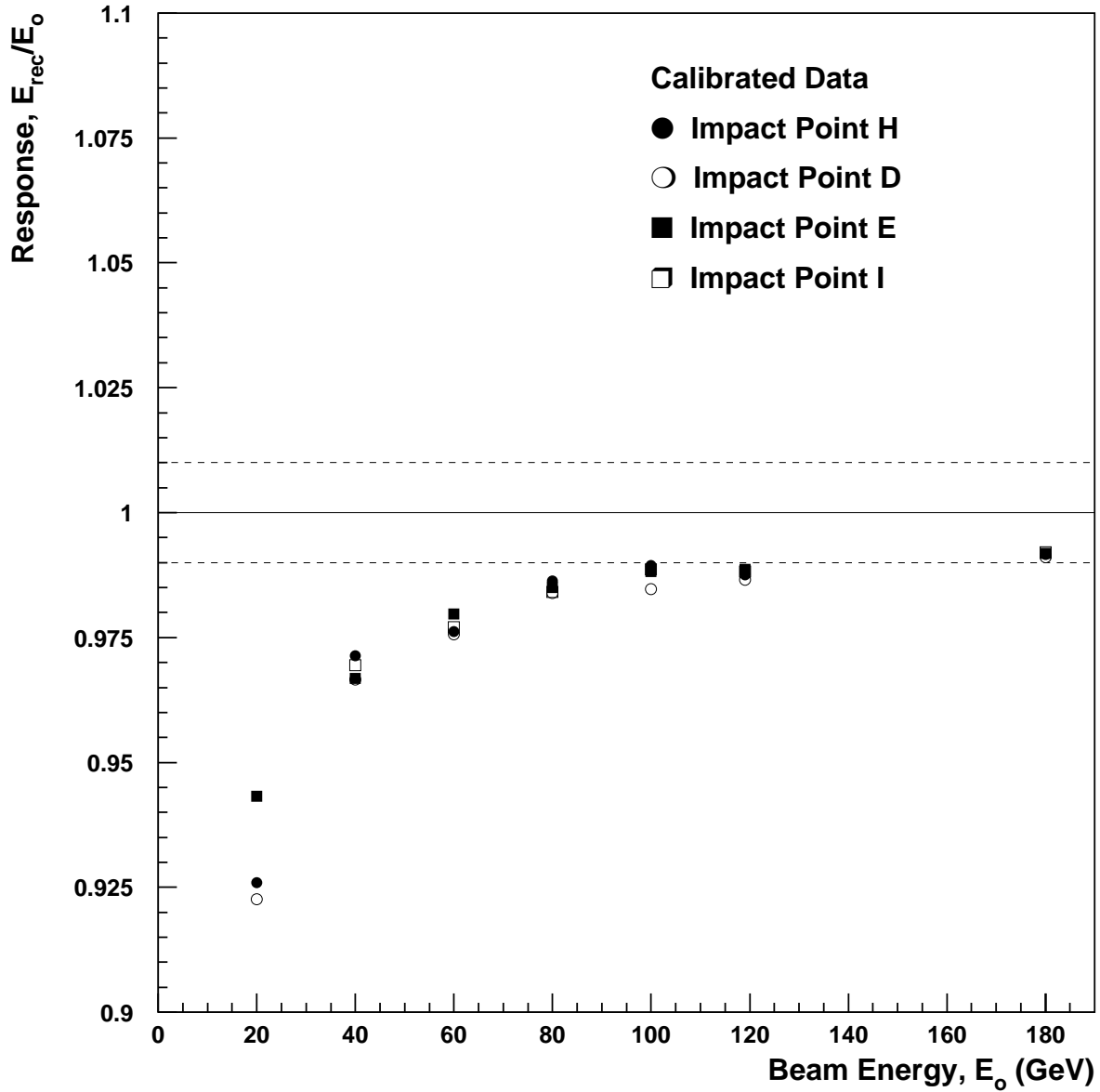


Figure 13: Response for pions at 4 different impact points

Pion Analysis

Effect of HV Problem in Module 2

- 1 dead sub-gap (of 4) in each LAr gap in first half of back compartment, lower voltage (1200V) in 1/4 gaps of back half of back compartment.
- Expected effect: signal $\approx 3/4$ of module 1 in back compartment due to dead gaps. Low voltage gaps are not expected to significantly affect results.
- The total energy (adc counts) in the third depth was compared for modules 1 and 2 for 180 GeV pions. The factor of $3/4$ is verified.
- HV problems should lead to different depth weighting in module 1 and 2 for the back depth. [Figure 15](#) shows the behaviour of the depth weights in the third compartment in modules 1 and 2. Again the factor of $3/4$ is verified at high energy.

Pion Analysis

Total adc in 3rd Depth for Points H and E

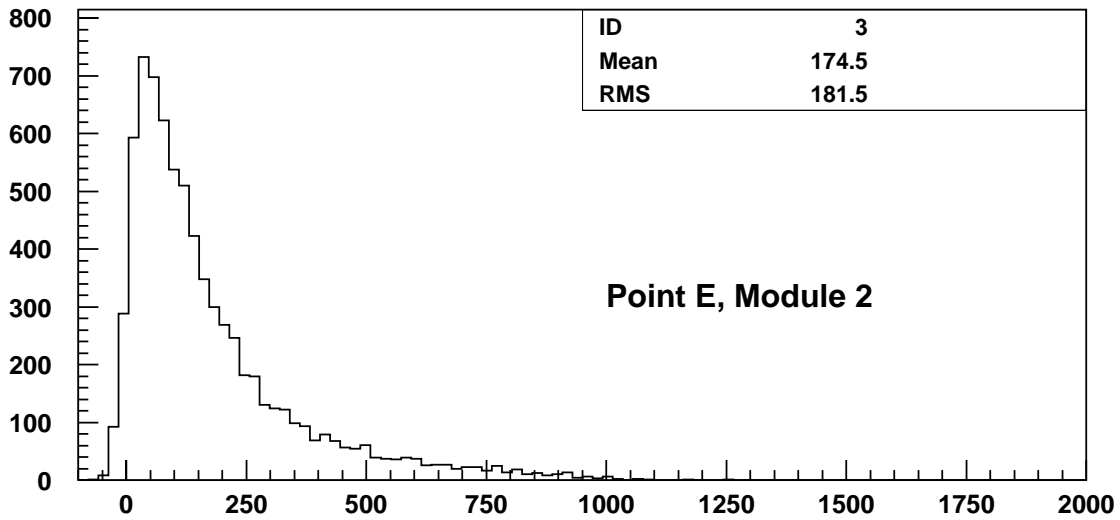
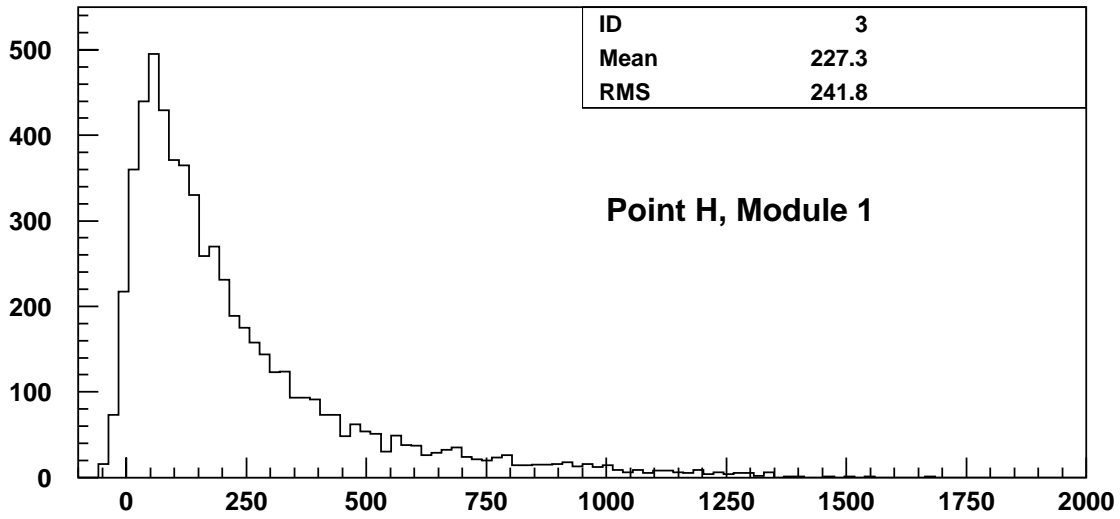


Figure 14: Total energy (adc) in the back compartment for 180 GeV pions .

Pion Analysis

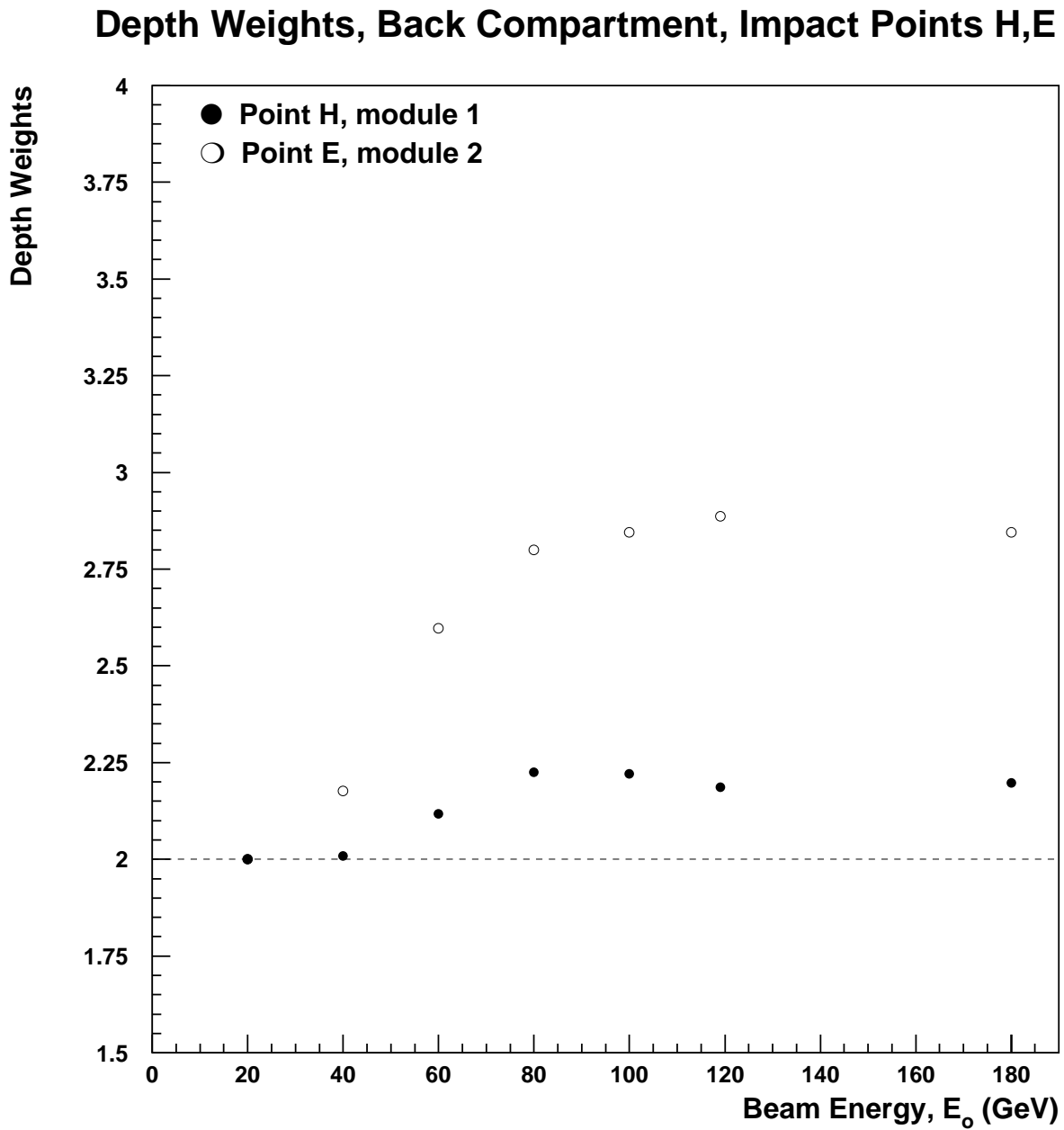


Figure 15: Behaviour of depth weights with energy in modules 1 and 2 .

Conclusions

- Digital filtering leads to a consistent treatment for all energies.
- Electron results energy resolution as expected and response varies within 1% at all impact points.
- subcluster signal shape effective in isolating pion sample (particularly at low energies) from “zero energy” events. Presence of large number of “zero energy” events not fully understood.
- Pion energy resolution (calibrated):

Module 1 D	Module 2 E
$\frac{109\%}{\sqrt{E_0}} \oplus 2.5\% \oplus \frac{2.3 \text{ GeV}}{E_0}$	$\frac{106\%}{\sqrt{E_0}} \oplus 2.2\% \oplus \frac{2.3 \text{ GeV}}{E_0}$
H	I
$\frac{88\%}{\sqrt{E_0}} \oplus 4.6\% \oplus \frac{3.9 \text{ GeV}}{E_0}$	

- Response for pions varies by up to 7%, consistent over impact positions .
- Energy dependent weights allow recovery of performance in HV-affected module 2.
- More data needed at 20 GeV.